

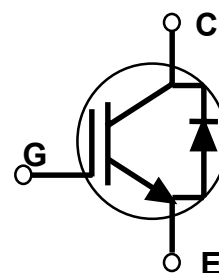
FEATURES

- * High Speed Switching
- * Low Saturation Voltage
: $V_{CE(sat)} = 2.0\text{ V}$ (at $I_C=60\text{A}$)
- * High Input Impedance
- * Built in Fast Recovery Diode

APPLICATIONS

- * Home Appliance
 - Induction Heater
 - IH JAR
 - Micro Wave Oven

TO-264



ABSOLUTE MAXIMUM RATINGS

Symbol	Characteristics		Rating	Unit
V _{CES}	Collector-Emitter Voltage		900	V
V _{GE}	Gate - Emitter Voltage		± 25	V
I _C	Continuous Collector Current	T _C = 25℃	60	A
		T _C = 100℃	42	
I _{CM (1)}	Pulsed Collector Current		120	A
P _D	Maximum Power Dissipation	T _C = 25℃	180	W
		T _C = 100℃	72	
T _j	Operating Junction Temperature		-55 ~ 150	℃
T _{stg}	Storage Temperature Range			
T _L	Soldering maximum lead temperature (1/8" from case for 10 seconds)		300	℃

Notes: (1) Repetitive rating : Pulse with limited by max. junction temperature

ELECTRICAL CHARACTERISTICS ($T_C=25^{\circ}\text{C}$)

Symbol	Characteristics	Test Conditions	Min	Typ	Max	Units
BV_{CES}	C - E Breakdown Voltage	$V_{GE} = 0V, I_C = 1\text{mA}$	900	-	-	V
$V_{GE(th)}$	G - E threshold voltage	$I_C = 60\text{mA}, V_{CE} = V_{GE}$	4.0	5.0	7.0	V
I_{CES}	Collector cutoff Current	$V_{CE} = V_{CES}, V_{GE} = 0V$	-	-	1.0	mA
I_{GES}	G - E leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$	-	-	500	nA
$V_{CE(sat)}$	Collector to Emitter saturation voltage	$V_{GE} = 15V, I_C = 60A$	-	2.0	2.7	V
Cies	Input capacitance	$V_{GE} = 0V, f = 1\text{MHz}$ $V_{CE} = 10V$	-	6500	-	pF
Coes	Output capacitance		-	250	-	pF
Cres	Reverse transfer capacitance		-	220	-	pF
td(on)	Turn on delay time	$V_{CC} = 600V, I_C = 60A$ $V_{GE} = 15V$ $R_G = 51\Omega$ Resistive load	-	250	400	ns
tr	Rise time		-	450	700	ns
td(off)	Turn off delay time		-	450	700	ns
tf	Fall time		-	250	400	ns
V_{EC}	Emitter-Collector Voltage	$I_E = 15A$	-	1.2	1.7	V
trr	Reverse recovery time	$I_E = 15A, di/dt = -200A/\mu s$	-	0.5	2.5	μs

THERMAL RESISTANCE

Symbol	Characteristics	Min	Typ	Max	Units
$R_{\theta JC}$	Junction-to-Case : IGBT	-	-	0.69	$^{\circ}\text{C/W}$
$R_{\theta JC}$	Junction-to-Case : Diode	-	-	2.08	$^{\circ}\text{C/W}$

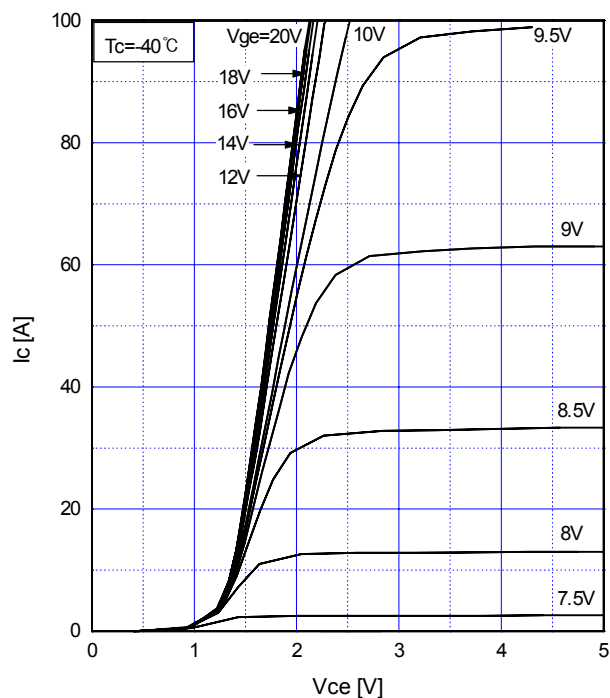


Fig.1 Typical Output Characteristics

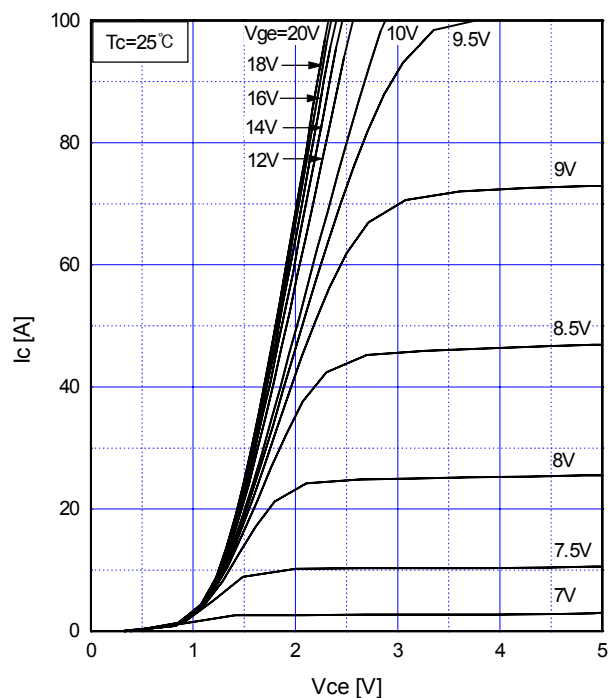


Fig.2 Typical Output Characteristics

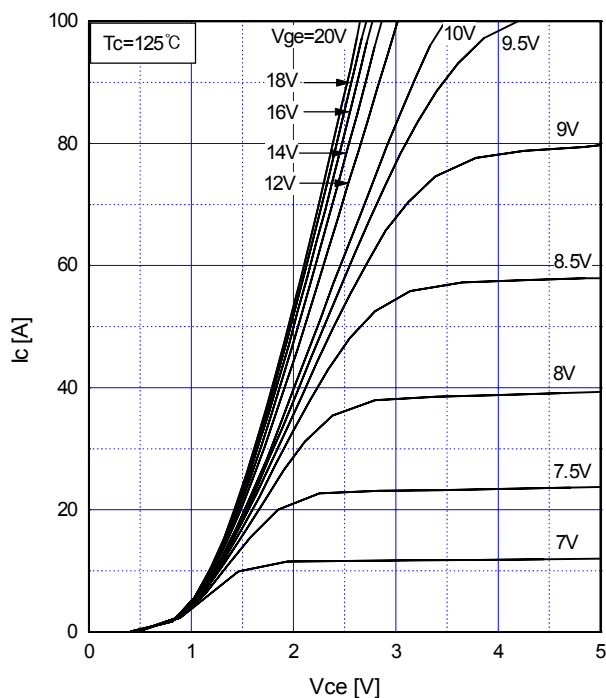


Fig.3 Typical Output Characteristics

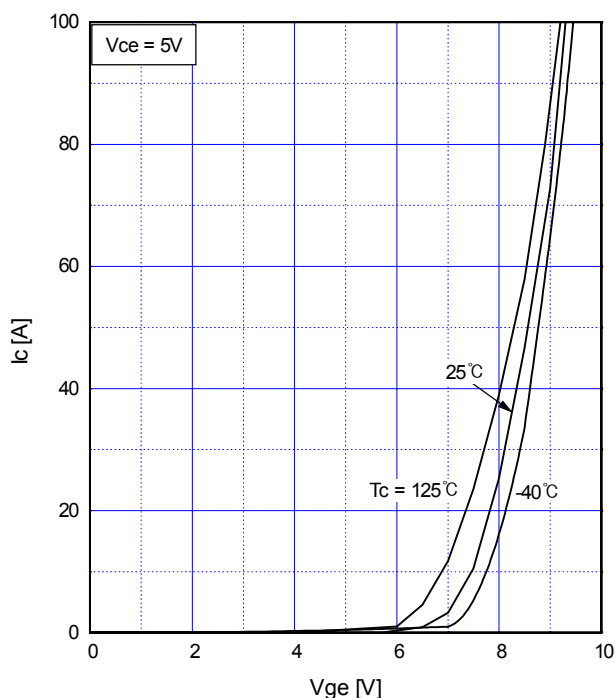


Fig.4 Typical Output Characteristics

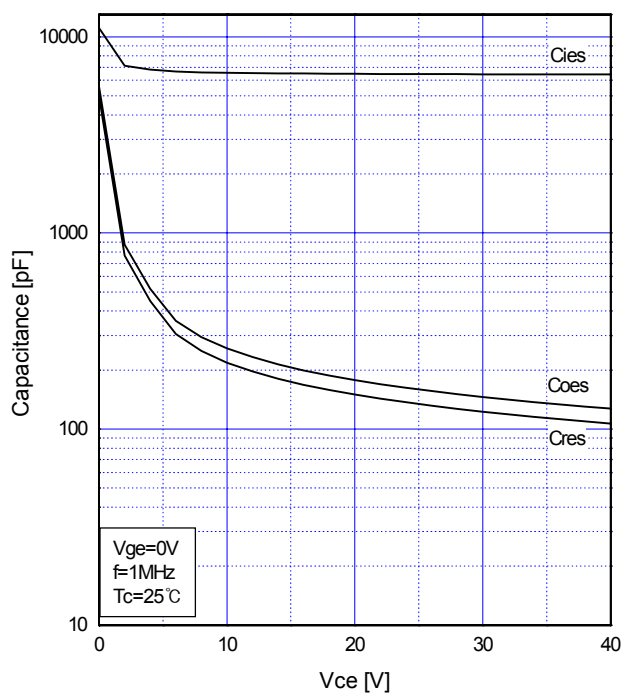


Fig.5 Typical Capacitance vs. Collector to Emitter Voltage

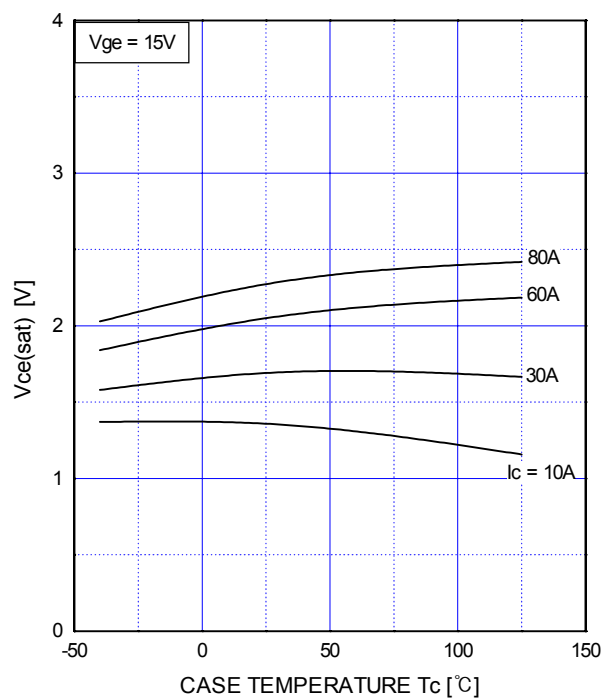


Fig.6 Collector to Emitter Saturation Voltage vs. Case Temperature

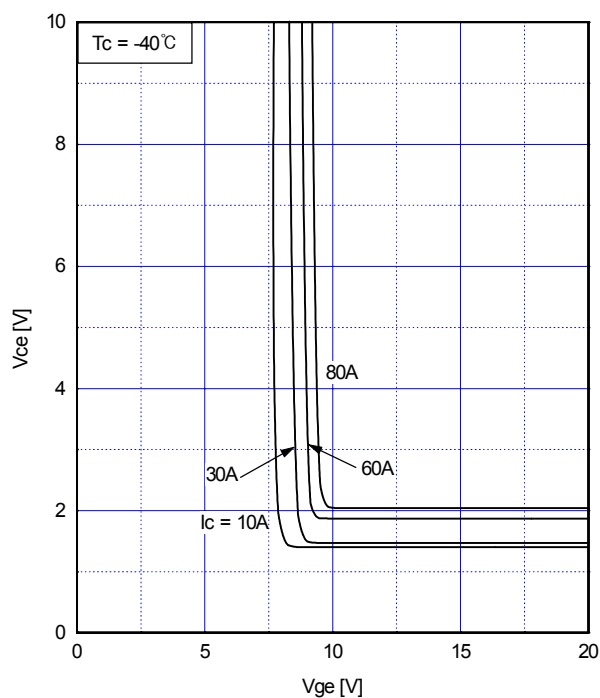


Fig.7 Collector to Emitter Voltage vs. Gate to Emitter Voltage

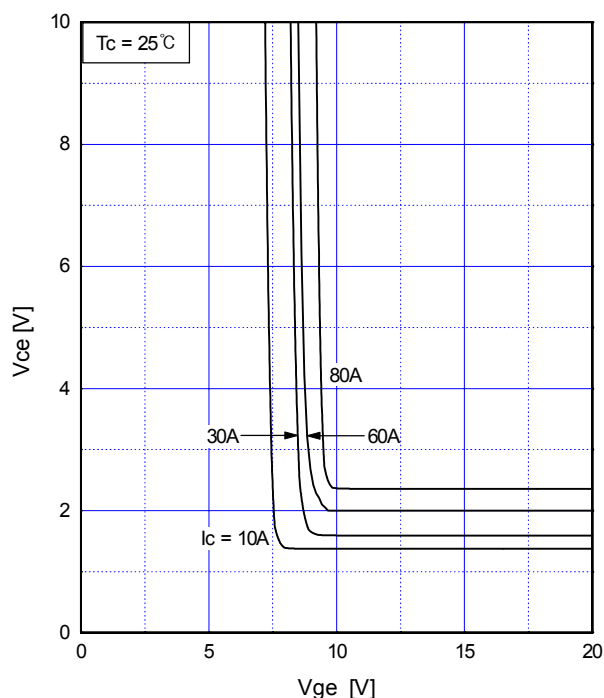


Fig.8 Collector to Emitter Voltage vs. Gate to Emitter Voltage

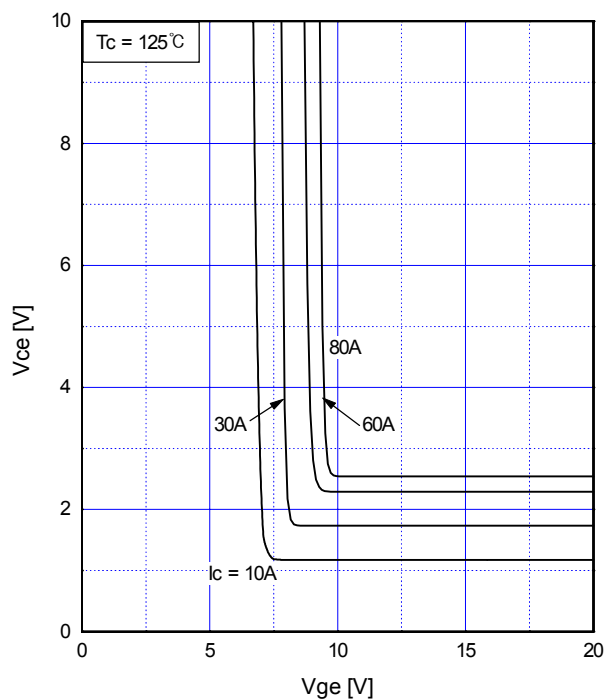


Fig.9 Collector to Emitter Voltage vs. Gate to Emitter Voltage

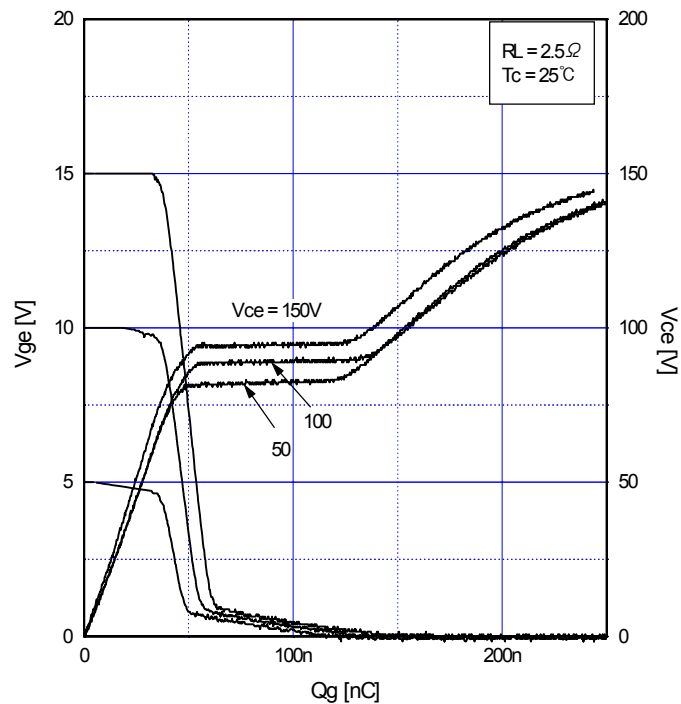


Fig.10 Gate Charge

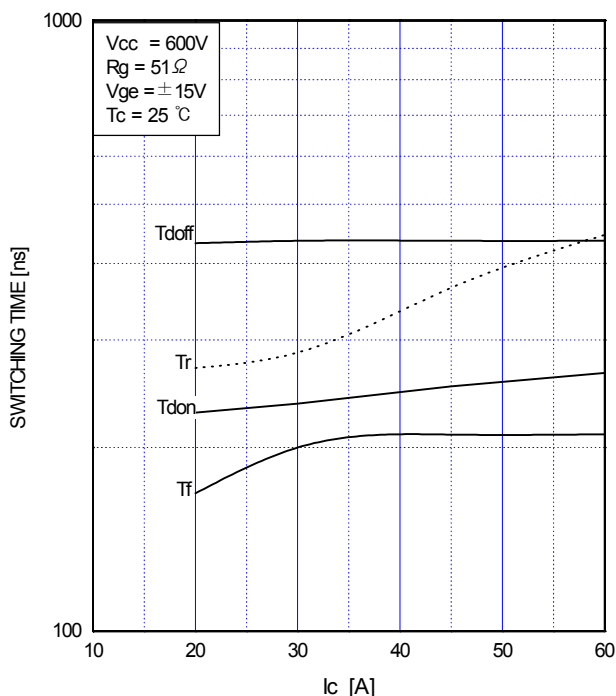


Fig.11 Collector Current vs. Switching time

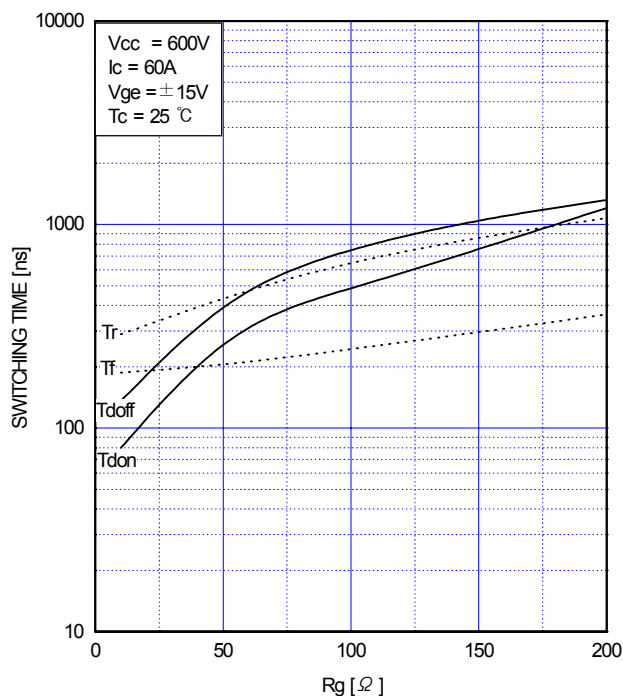


Fig.12 Gate Resistance vs. Switching time

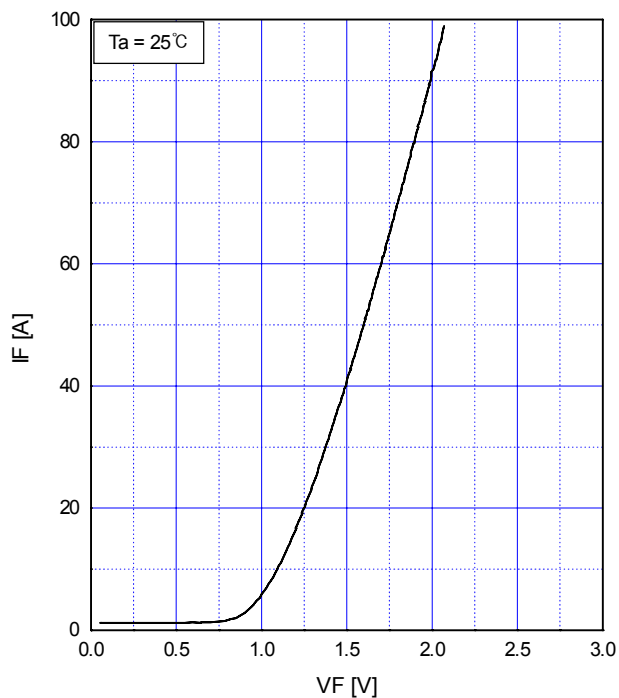


Fig.13 Emitter to Collector Forward Voltage Characteristics

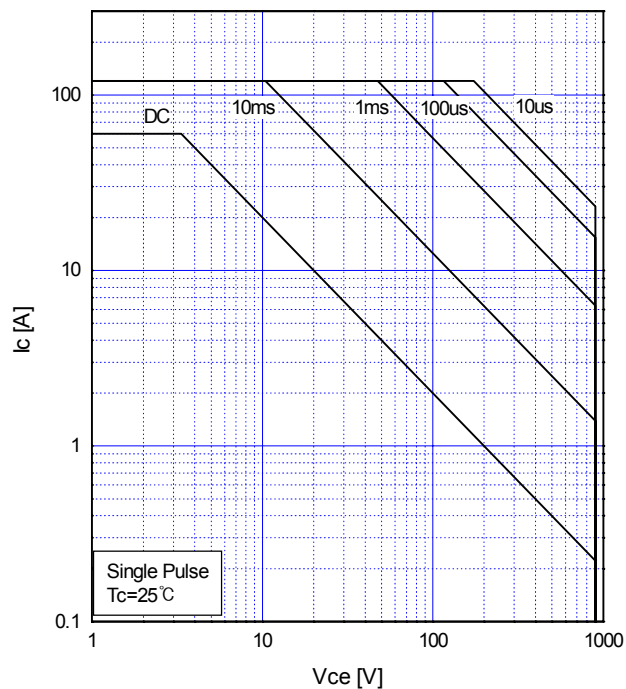


Fig.14 Safe Operating Area

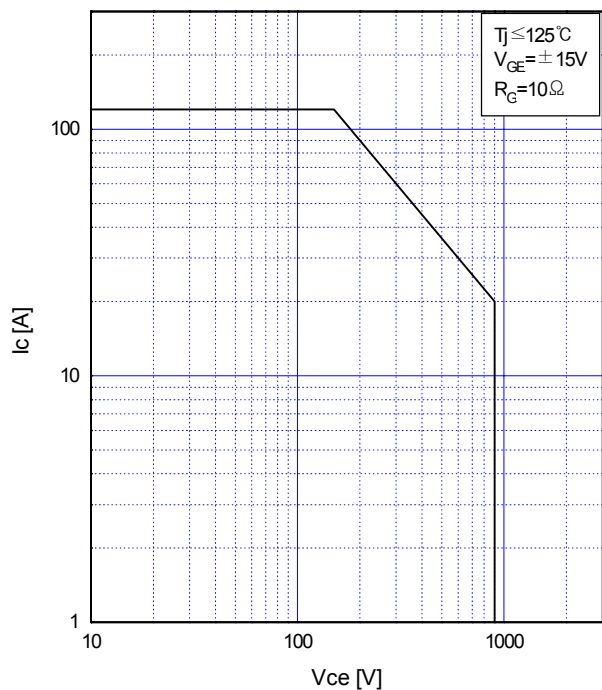


Fig.15 Reverse Bias SOA